

<b>Notice of References Cited</b>	Application/Control No. 09/763,440	Applicant(s)/Patent Under Reexamination DE HAAN, WIEBE	
	Examiner Vincent F. Boccio	Art Unit 2616	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,577,812 b1	06-2003	Kikuchi et al.	386/105
	B	US-6,282,320 b1	08-2001	Hasegawa et al.	386/109
	C	US-6,148,140 a	11-2000	Okada et al.	386/105
	D	US-6,118,924 a	09-2000	Nakatani et al.	386/70
	E	US-6,112,226 a	08-2000	Weaver et al.	386/124
	F	US-5,949,953 a	09-1999	Shirakawa et al.	386/70
	G	US-5,870,523 a	02-1999	Kikuchi et al.	386/111
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.